

LIST OF ART CITED BY APPLICANT
(Use sever of sheets if necessary)

In re Application of: Rainer BLUM et al.

Serial No.: Herewith

Filed: July 25, 2001

U.S. PATENT DOCUMENTS

Examiner Initial		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AD						
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	AI						
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	AK						

FOREIGN PATENT DOCUMENTS

Examiner Initial		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MF	AL	196 00 136 A1	10.07.97	DE	C09D	201/02	<input checked="" type="checkbox"/>	X
MF	AM	196 00 152 A1	10.07.97	DE	C09D	167/07	<input checked="" type="checkbox"/>	X
	AN							
	AO							
	AP							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

MF	AR	English Abstract for DE 196 00 152 A1.
MF	AS	English Abstract DE 196 00 136 A1
	AT	

EXAMINER

Michael J. V.

DATE CONSIDERED

7/16/04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*Applicant has modified this form by deleting the word "prior".

Atty. docket No. IN-5510

Serial No. 09/890,019

Applicant(s) : BLUM et al.

Filing Date July 25, 2001

Group

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Examiner Initial		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MF	AA	4,163,810	8/7/79	McGinniss	427	54	9/15/78
MF	AB	4,129,488	12/12/78	McGinniss	204	159.19	11/8/76
MF	AC	5,576,386	11/19/96	Kempter et al.	526	88	1/28/93
MF	AD	5,690,569	11/25/97	Ledvina et al.	474	111	3/13/96
MF	AE	5,206,417	4/27/93	Boettcher et al.	560	137	12/18/91
MF	AF	5,223,645	6/29/93	Barwich et al.	564	158	9/23/91
MF	AG	5,068,305	11/16/91	Meixner et al.	528	49	7/20/90
MF	AH	3,445,336	5/20/69	Tanaka et al.	195	28	6/24/64
MF	AI	5,726,258	3/10/98	Fischer et al.	526	64	7/1/96
MF	AJ	5,202,483	4/13/93	Rehmer et al.	564	207	3/1/91
MF	AK	5,620,751	4/15/97	Brindoepeke et al.	427	506	3/14/96

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Examiner Initial		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MF	AL	WO 82/02387 ✓	22.07.82	EP	C08F	2/02	X	✓
MF	AM	WO 95/27742 ✓	19.10.95	EP	C08F	18/04	X	✓
MF	AN	0 636 669 A2	30.07.93	EP	C09D	167/06	X	✓
MF	AO	28 48 966 A1 ✓	22.05.80	DE	C10K	1/30	✓	X
MF	AP	38 20 463 A1	21.12.89	DE	C07C	125/06	✓	X
MF	AR	40 07 318 A1	12.09.91	DE	C07C	233/31	✓	X
MF	AS	0 486 897 A1	22.11.90	EP	C07C	235/20	✓	X

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MF	AT	English Abstract for DE 284 8966
MF	AU	English Abstract for DE 197 09465
MF	AV	English Abstract for EP 650 985 ✓

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MF	AA	5,527,859	6/18/96	Kempter et al.	525	301	8/2/95
MF	AB	5,484,850	6/16/96	Kempter et al.	525	286	10/28/94
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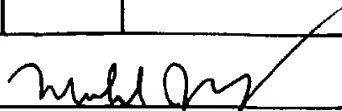
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MF	AL	1 570 027	09.04.70	DE	C07d	/	/	X
MF	AM	0 650 979 A1	03.11.93	EP	C08F	8/00	/	X
MF	AN	0 650 985 A1	03.11.93	EP	C08F	220/12	/	X
MF	AO	0 650 978 A1	03.11.93	EP	C08F	8/00	/	X
MF	AP	0 410 242 A2	14.07.90	EP	C09D	5/03	/	X
MF	AR	0 585 742 B1	19.08.93	EP	C09D	167/06	/	X
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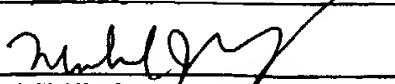
FOREIGN PATENT DOCUMENTS

Examiner Initial		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MF	AL	197 09 465 A1 ✓	17.09.98	DE	B05D	7/26	✓	X
MF	AM	197 09 476 A1	13.03.96	DE	F16H	7/18	✓	X
MF	AN	195 24 182 A1	09.01.97	DE	C08F	212/08	✓	X
MF	AO	0 554 783 A1	28.01.93	EP	B01J	19/18	✓	X
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